MOSFET - Power, Single

N-Channel

80 V, 29 mΩ, 22 A

NVMFS6H864NL

Features

- Small Footprint (5x6 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- NVMFS6H864NLWF Wettable Flank Option for Enhanced Optical Inspection
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V_{DSS}	80	V
Gate-to-Source Voltage	е		V _{GS}	±20	V
Continuous Drain		T _C = 25°C	I _D	22	Α
Current R _{θJC} (Notes 1, 3)	Steady	T _C = 100°C		15	
Power Dissipation	State	T _C = 25°C	P_{D}	33	W
R _{θJC} (Note 1)		T _C = 100°C		17	
Continuous Drain	in $T_A = 25^{\circ}C$		I _D	7.0	Α
Current R _{θJA} (Notes 1, 2, 3)	Steady State	T _A = 100°C		5	
Power Dissipation		T _A = 25°C	P_{D}	3.5	W
R _{θJA} (Notes 1, 2)		T _A = 100°C		1.7	
Pulsed Drain Current	T _A = 25	°C, t _p = 10 μs	I _{DM}	97	Α
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +175	°C
Source Current (Body Diode)			Is	28	Α
Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 1.0 A)			E _{AS}	68	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{\theta JC}$	4.6	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	43	

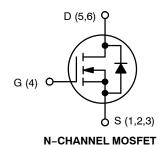
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- 3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

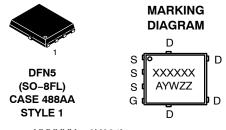


ON Semiconductor®

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V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX	
80 V	29 mΩ @ 10 V	22 A	
	38 mΩ @ 4.5 V	22 A	





XXXXXX = 6H864L

(NVMFS6H864NL) or

864LWF

(NVMFS6H864NLWF) A = Assembly Location

= Year

W = Work Week

ZZ = Lot Traceability

ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•				•	•	•
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D = 250 μA		80			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /				47.8		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 V$	T _J = 25 °C			10	
		V _{DS} = 80 V	T _J = 125°C			100	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS}	_S = 20 V			100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$, $I_D = 20 \mu A$		1.2		2.0	V
Threshold Temperature Coefficient	V _{GS(TH)} /T _J				-5.2		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 5 A		24	29	mΩ
		V _{GS} = 4.5 V	I _D = 5 A		30	38	mΩ
Forward Transconductance	9FS	V _{DS} = 8 V, I _D	₎ = 5 A		24		S
CHARGES, CAPACITANCES & GATE RES	SISTANCE						
Input Capacitance	C _{ISS}				431		
Output Capacitance	Coss	V _{GS} = 0 V, f = 1 MH	z, V _{DS} = 40 V		55		pF
Reverse Transfer Capacitance	C _{RSS}				4		1
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 40 V; I _D = 10 A			9		
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 4.5 V, V _{DS} = 40 V; I _D = 10 A			1		nC
Gate-to-Source Charge	Q_{GS}				1.7		
Gate-to-Drain Charge	Q_GD				1.4		
Plateau Voltage	V_{GP}				3.2		٧
Total Gate Charge	Q _{G(TOT)}				4		nC
SWITCHING CHARACTERISTICS (Note 5)							
Turn-On Delay Time	t _{d(ON)}				8		
Rise Time	t _r	V _{GS} = 4.5 V, V _D	_S = 64 V,		6		- ns
Turn-Off Delay Time	t _{d(OFF)}	V_{GS} = 4.5 V, V_{D} I_{D} = 10 A, R_{G}	= 2.5 Ω		12		
Fall Time	t _f				4		1
DRAIN-SOURCE DIODE CHARACTERIST	rics						
Forward Diode Voltage	V_{SD}	V _{GS} = 0 V,	T _J = 25°C		0.82	1.2	.,
		$I_S = 5 A$	T _J = 125°C		0.69		
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, dIS/dt} = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 10 \text{ A}$			25		
Charge Time	t _a				17		ns
Discharge Time	t _b				8		1
Reverse Recovery Charge	Q _{RR}				16		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulse Test: pulse width $\leq 300~\mu s$, duty cycle $\leq 2\%$.

5. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

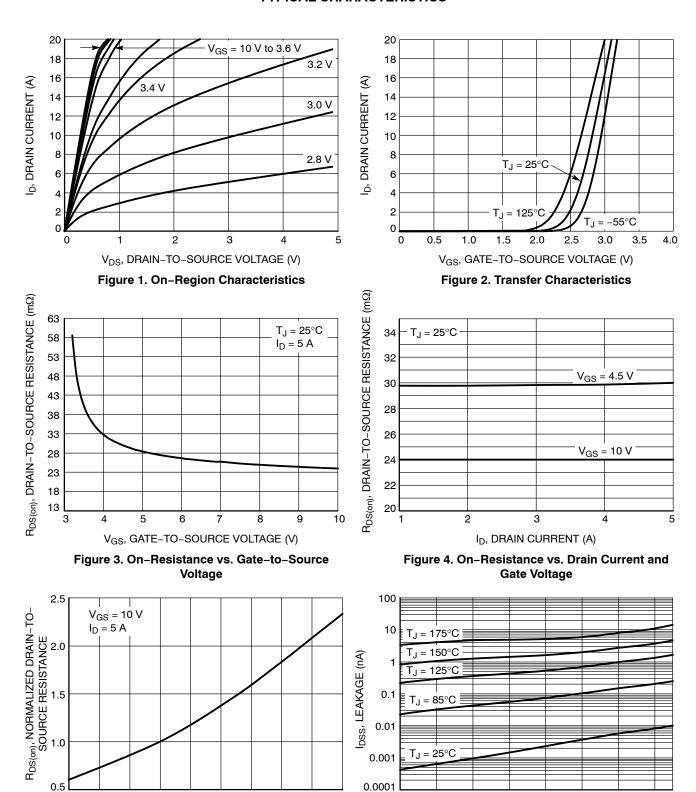


Figure 5. On–Resistance Variation with Temperature

T_J, JUNCTION TEMPERATURE (°C)

75

100

125

150

175

15

-50

-25

0

Figure 6. Drain-to-Source Leakage Current vs. Voltage

V_{DS}, DRAIN-TO-SOURCE VOLTAGE (V)

45

55

65

75

35

TYPICAL CHARACTERISTICS

SOURCE CURRENT (A)

<u>.</u>

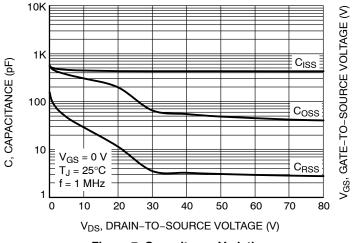


Figure 7. Capacitance Variation

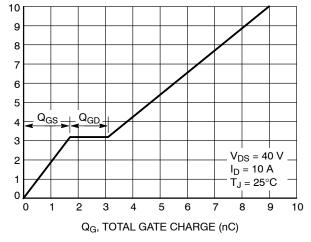


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

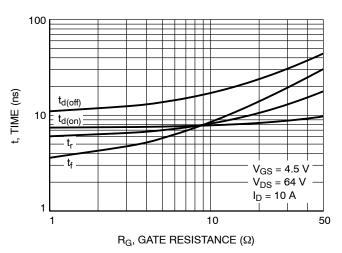


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

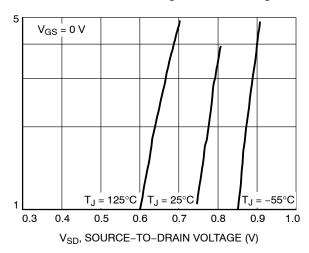


Figure 10. Diode Forward Voltage vs. Current

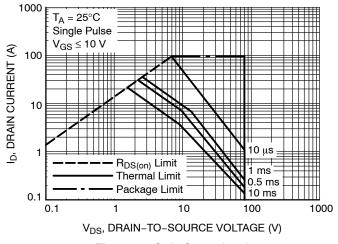


Figure 11. Safe Operating Area

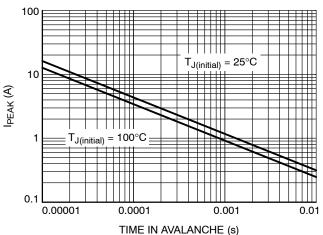


Figure 12. Maximum Drain Current vs. Time in Avalanche

TYPICAL CHARACTERISTICS

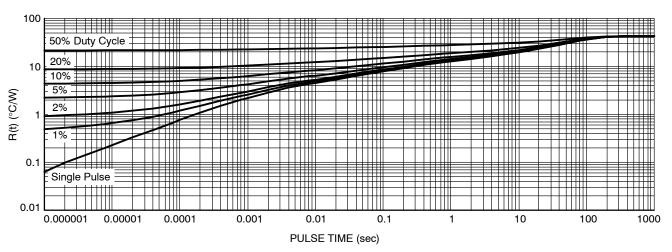


Figure 13. Thermal Response

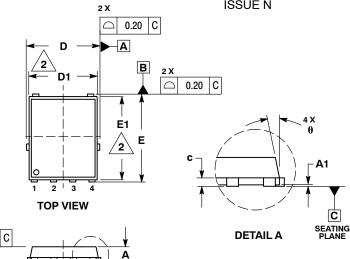
DEVICE ORDERING INFORMATION

Device	Marking	Package	Shipping [†]
NVMFS6H864NLT1G	6H864L	DFN5 (Pb-Free)	1500 / Tape & Reel
NVMFS6H864NLWFT1G	864LWF	DFN5 (Pb-Free, Wettable Flanks)	1500 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS



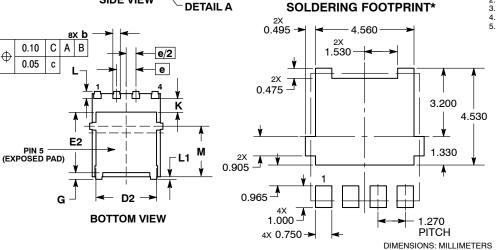


- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETER.
- DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE

	MILLIMETERS			
DIM	MIN	NOM	MAX	
Α	0.90	1.00	1.10	
A1	0.00		0.05	
b	0.33	0.41	0.51	
С	0.23	0.28	0.33	
D	5.00	5.15	5.30	
D1	4.70	4.90	5.10	
D2	3.80	4.00	4.20	
E	6.00	6.15	6.30	
E1	5.70	5.90	6.10	
E2	3.45	3.65	3.85	
е	1.27 BSC			
G	0.51	0.575	0.71	
K	1.20	1.35	1.50	
L	0.51	0.575	0.71	
L1	0.125 REF			
M	3.00	3.40	3.80	
θ	0 °		12 °	

- STYLE 1: PIN 1. SOURCE 2. SOURCE 3. SOURCE

 - GATE
 - DRAIN



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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